

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,456	CHAMPION ET AL.	
Examiner	Art Unit	
Karie O'Neill	1745	

SEARCHED						
Class	Subclass	Date	Examiner			
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		INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Dah-wei Yuan Re: arguments, prior art	6/28/2007	као		